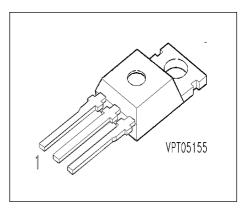
#### **SIPMOS** ® Power Transistor

- P channel
- Enhancement mode
- Avalanche rated



Pin 1	Pin 2	Pin 3
G	D	S

Туре	V <sub>DS</sub>	I <sub>D</sub>	R <sub>DS(on)</sub>	Package	Ordering Code
BUZ 271	-50 V	-22 A	0.15 Ω	TO-220 AB	C67078-S1453-A2

#### **Maximum Ratings**

Parameter	Symbol	Values	Unit
Continuous drain current	I <sub>D</sub>		Α
$T_{\rm C}$ = 26 °C		-22	
Pulsed drain current	/ <sub>Dpuls</sub>		
$T_{\rm C}$ = 25 °C		-88	
Avalanche energy, single pulse	E <sub>AS</sub>		mJ
$I_{\rm D}$ = -22 A, $V_{\rm DD}$ = -25 V, $R_{\rm GS}$ = 25 $\Omega$			
$L = 413 \mu H, T_j = 25 °C$		200	
Gate source voltage	V <sub>GS</sub>	± 20	V
Power dissipation	P <sub>tot</sub>		W
$T_{\rm C}$ = 25 °C		125	
Operating temperature	$T_{\rm j}$	-55 <b>+</b> 150	°C
Storage temperature	T <sub>stg</sub>	-55 <b>+</b> 150	
Thermal resistance, chip case	R <sub>thJC</sub>	≤1	K/W
Thermal resistance, chip to ambient	R <sub>thJA</sub>	≤ 75	
DIN humidity category, DIN 40 040		Е	
IEC climatic category, DIN IEC 68-1		55 / 150 / 56	



## **Electrical Characteristics,** at $T_j = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Static Characteristics					
Drain- source breakdown voltage	V <sub>(BR)DSS</sub>				V
$V_{GS} = 0 \text{ V}, I_{D} = -0.25 \text{ mA}, T_{j} = 25 \text{ °C}$		-50	-	-	
Gate threshold voltage	V <sub>GS(th)</sub>				
$V_{GS}=V_{DS}$ , $I_{D}=1$ mA		-2.1	-3	-4	
Zero gate voltage drain current	I <sub>DSS</sub>				μA
$V_{\text{DS}}$ = -50 V, $V_{\text{GS}}$ = 0 V, $T_{\text{j}}$ = 25 °C		-	-0.1	-1	
$V_{\text{DS}}$ = -50 V, $V_{\text{GS}}$ = 0 V, $T_{\text{j}}$ = 125 °C		-	-10	-100	
Gate-source leakage current	I <sub>GSS</sub>				nA
$V_{GS} = -20 \text{ V}, \ V_{DS} = 0 \text{ V}$		-	-10	-100	
Drain-Source on-resistance	R <sub>DS(on)</sub>				Ω
$V_{GS} = -10 \text{ V}, I_{D} = -14 \text{ A}$		-	0.12	0.15	



## **Electrical Characteristics**, at $T_j = 25$ °C, unless otherwise specified

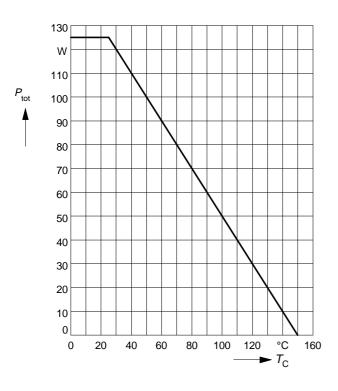
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Dynamic Characteristics					
Transconductance	g <sub>fs</sub>				S
$V_{DS} \ge 2 * I_D * R_{DS(on)max}, I_D = -14 A$		1.5	4	-	
Input capacitance	$C_{iss}$				pF
$V_{GS} = 0 \text{ V}, \ V_{DS} = -25 \text{ V}, \ f = 1 \text{ MHz}$		-	2000	2700	
Output capacitance	$C_{\text{oss}}$				
$V_{GS} = 0 \text{ V}, \ V_{DS} = -25 \text{ V}, \ f = 1 \text{ MHz}$		-	650	975	
Reverse transfer capacitance	$C_{rss}$				
$V_{GS} = 0 \text{ V}, \ V_{DS} = -25 \text{ V}, \ f = 1 \text{ MHz}$		-	250	375	
Turn-on delay time	$t_{d(on)}$				ns
$V_{\rm DD}$ = -30 V, $V_{\rm GS}$ = -10 V, $I_{\rm D}$ = -2.95 A					
$R_{\rm GS} = 50 \ \Omega$		-	30	45	
Rise time	<i>t</i> <sub>r</sub>				
$V_{\rm DD}$ = -30 V, $V_{\rm GS}$ = -10 V, $I_{\rm D}$ = -2.95 A					
$R_{\rm GS} = 50 \ \Omega$		-	120	180	
Turn-off delay time	$t_{d(off)}$				
$V_{\rm DD}$ = -30 V, $V_{\rm GS}$ = -10 V, $I_{\rm D}$ = -2.95 A					
$R_{\rm GS} = 50 \ \Omega$		-	130	175	
Fall time	t <sub>f</sub>				
$V_{\rm DD}$ = -30 V, $V_{\rm GS}$ = -10 V, $I_{\rm D}$ = -2.95 A					
$R_{\rm GS} = 50 \ \Omega$		-	140	190	

## **Electrical Characteristics,** at $T_j = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Reverse Diode					
Inverse diode continuous forward current	Is				А
<i>T</i> <sub>C</sub> = 25 °C		-	-	-22	
Inverse diode direct current,pulsed	/ <sub>SM</sub>				
<i>T</i> <sub>C</sub> = 25 °C		-	-	-88	
Inverse diode forward voltage	$V_{\mathrm{SD}}$				V
$V_{GS} = 0 \text{ V}, I_{F} = -44 \text{ A}$		-	-1.25	-1.7	
Reverse recovery time	t <sub>rr</sub>				ns
$V_{R}$ = -30 V, $I_{F}=I_{S}$ , $dI_{F}/dt$ = 100 A/ $\mu$ s		-	90	-	
Reverse recovery charge	Q <sub>rr</sub>				μC
$V_{\rm R}$ = -30 V, $I_{\rm F} = I_{\rm S}$ , $di_{\rm F}/dt$ = 100 A/ $\mu$ s		-	0.23	-	

#### **Power dissipation**

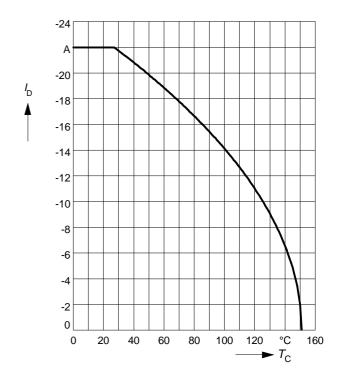
$$P_{\mathsf{tot}} = f(T_{\mathsf{C}})$$



#### **Drain current**

$$I_{\mathsf{D}} = f(T_{\mathsf{C}})$$

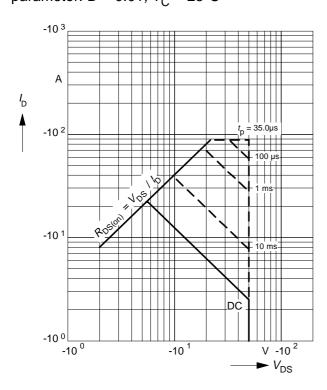
parameter:  $V_{GS} \ge -10 \text{ V}$ 



#### Safe operating area

$$I_{\mathsf{D}} = f(V_{\mathsf{DS}})$$

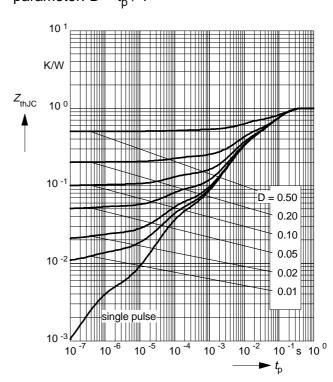
parameter: D = 0.01,  $T_C = 25$ °C



#### **Transient thermal impedance**

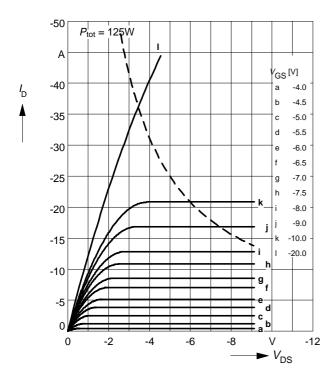
$$Z_{\mathsf{th\ JC}} = f(t_{\mathsf{p}})$$

parameter:  $D = t_p / T$ 



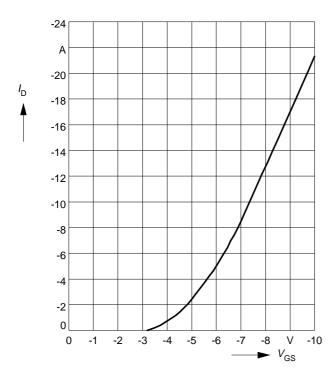
#### Typ. output characteristics

 $I_{\rm D} = f(V_{\rm DS})$  parameter:  $t_{\rm p} = 80~\mu{\rm s}$ 



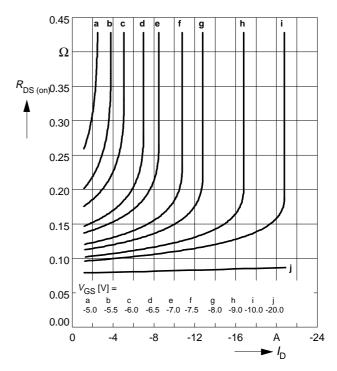
Typ. transfer characteristics  $I_{\rm D}$  =  $f(V_{\rm GS})$ 

parameter:  $t_p = 80 \mu s$  $V_{DS} \ge 2 \times I_D \times R_{DS(on)max}$ 



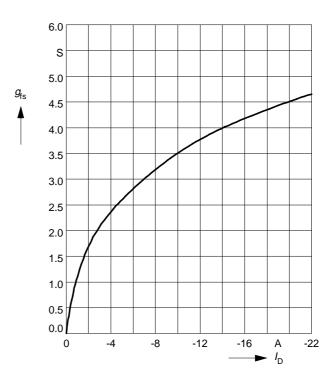
#### Typ. drain-source on-resistance

 $R_{\text{DS (on)}} = f(I_{\text{D}})$  parameter:  $V_{\text{GS}}$ 



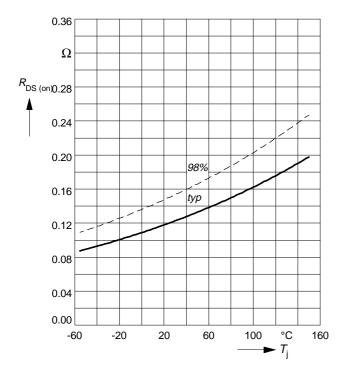
#### Typ. forward transconductance $g_{fs} = f(I_D)$

parameter:  $t_p = 80 \mu s$ ,  $V_{DS} \ge 2 \times I_D \times R_{DS(on)max}$ 



#### **Drain-source on-resistance**

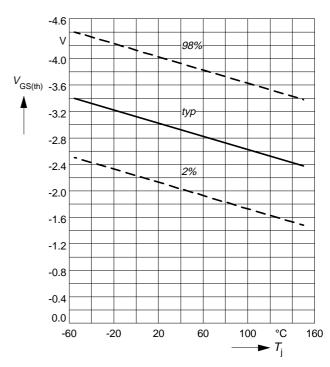
 $R_{\rm DS~(on)} = f(T_{\rm j})$  parameter:  $I_{\rm D}$  = -14 A,  $V_{\rm GS}$  = -10 V



#### Gate threshold voltage

 $V_{\text{GS (th)}} = f(T_{\text{j}})$ 

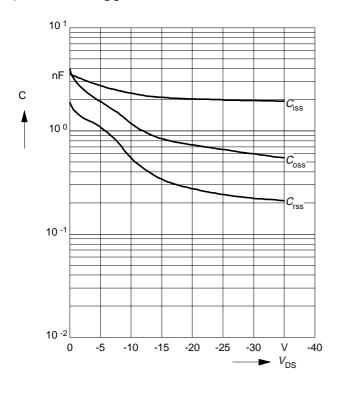
parameter:  $V_{GS} = V_{DS}$ ,  $I_{D} = 1 \text{ mA}$ 



#### Typ. capacitances

 $C = f(V_{DS})$ 

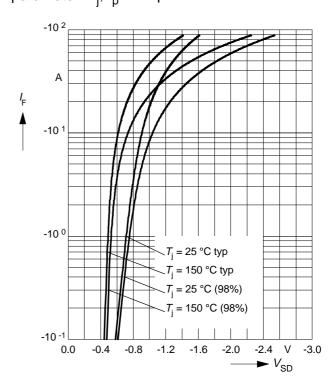
parameter:  $V_{GS} = 0V$ , f = 1MHz



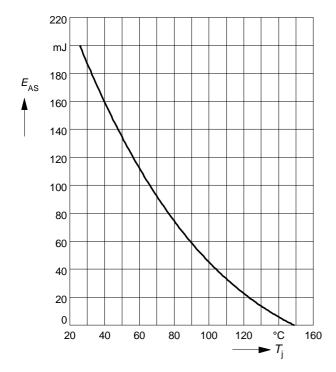
#### Forward characteristics of reverse diode

 $I_{\mathsf{F}} = f(V_{\mathsf{SD}})$ 

parameter:  $T_i$ ,  $t_p = 80 \mu s$ 

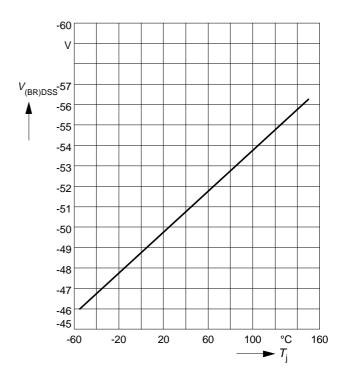


# Avalanche energy $E_{\rm AS} = f(T_{\rm j})$ parameter: $I_{\rm D}$ = -22 A, $V_{\rm DD}$ = -25 V $R_{\rm GS}$ = 25 $\Omega$ , L = 413 $\mu{\rm H}$



#### Drain-source breakdown voltage

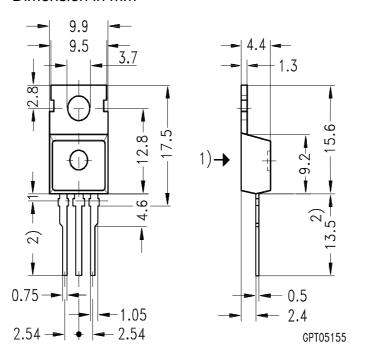
$$V_{(\mathsf{BR})\mathsf{DSS}} = f(T_{\mathsf{j}})$$



#### **Package Outlines**

TO-220 AB

Dimension in mm



- 1) punch direction, burr max. 0.04
- 2) dip tinning
- 3) max. 14.5 by dip tinning press burr max. 0.05